#### STD26P3LLH6



# P-channel 30 V, 0.024 Ω typ., 12 A, STripFET™ VI DeepGATE™ Power MOSFET in a DPAK package

Datasheet - production data

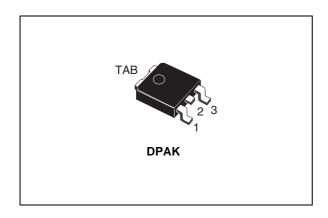
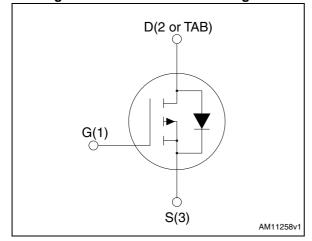


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>TOT</sub>
STD26P3LLH6	30 V	$0.030~\Omega^{(1)}$	12 A	40 W

- 1. @ V<sub>GS</sub>= 10 V
- $\bullet \quad \mathsf{R}_{\mathsf{DS}(\mathsf{on})} \ ^* \ \mathsf{Q}_\mathsf{g} \ \mathsf{industry} \ \mathsf{benchmark}$
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate input resistance

#### **Applications**

- · Switching applications
- LCC converters, resonant converters

#### **Description**

This device is a P-channel Power MOSFET developed using the  $\boldsymbol{\theta}^{th}$  generation of STripFETTM DeepGATETM technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest  $R_{DS(on)}$  in all packages

Table 1. Device summary

Order code	Marking	Package	Packaging
STD26P3LLH6	26P3LLH6	DPAK	Tape and reel

Note: For the P-channel Power MOSFETs the actual polarity of the voltages and the current must be reversed.

Contents STD26P3LLH6

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STD26P3LLH6 Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltag	30	V
V <sub>GS</sub>	Gate-source voltage	±20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	12	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	8.5	Α
I <sub>DM</sub> (1)(2)	Drain current (pulsed)	48	Α
P <sub>TOT</sub> (1)	Total dissipation at T <sub>C</sub> = 25 °C	40	W
T <sub>stg</sub>	Storage temperature	-55 to 175	°C
T <sub>j</sub>	Max. operating junction temperature	175	°C

<sup>1.</sup> Limited by wire bonding.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	3.75	°C/W

Note:

For the P-channel Power MOSFETs the actual polarity of the voltages and the current must be reversed.

<sup>2.</sup> Pulse width limited by safe operating area.

Electrical characteristics STD26P3LLH6

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown Voltage	$I_D = 250 \mu\text{A},  V_{GS} = 0$	30			V
lace	Zero gate voltage drain	$V_{DS} = 30 \text{ V}, (V_{GS} = 0)$			1	μΑ
טיטי	I <sub>DSS</sub> current V <sub>D</sub>	$V_{DS} = 30 \text{ V, Tc} = 125 \text{ °C}$			10	μΑ
I <sub>GSS</sub>	Gate body leakage current	$V_{GS} = \pm 20 \text{ V}, (V_{DS} = 0)$			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		2.5	٧
<b>D</b>	Static drain-source on-	$V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$		0.024	0.03	Ω
R <sub>DS(on)</sub>	resistance	$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$		0.038	0.045	Ω

Table 5. Dynamic

Symbol	Parameter	ter Test conditions		Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	1450	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f=1 MHz,	-	178	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	$V_{GS} = 0$	-	120	-	pF
Qg	Total gate charge	V <sub>DD</sub> = 24 V, I <sub>D</sub> = 12 A	-	12	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 4.5 V	-	4.4	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 14)	-	5	-	nC
$R_{G}$	Gate input resistance	f = 1 MHz gate bias Bias = 0 test signal level = 20 mV open drain	-	1.8	-	Ω

Note: For the P-channel Power MOSFETs the actual polarity of the voltages and the current must be reversed.

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Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	15	-	ns
t <sub>r</sub>	Rise time	$V_{DD} = 24 \text{ V}, I_{D} = 1.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	15	-	ns
t <sub>d(off)</sub>	Turn-off delay time	$G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 13)	-	24	-	ns
t <sub>f</sub>	Fall time		-	21	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		12	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		48	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 12 A, V <sub>GS</sub> = 0	-		1.1	٧
t <sub>rr</sub>	Reverse recovery time $I_{SD} = 12 \text{ A}$ ,		-	15		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/μs, V <sub>DD</sub> = 16 V	-	6.5		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 15)	-	0.9		Α

<sup>1.</sup> Pulse width limited by safe operating area

Note:

For the P-channel Power MOSFETs the actual polarity of the voltages and the current must be reversed.

<sup>2.</sup> Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%

Electrical characteristics STD26P3LLH6

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

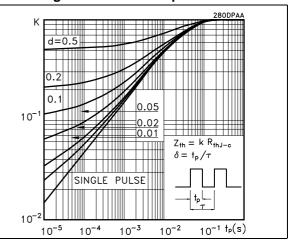
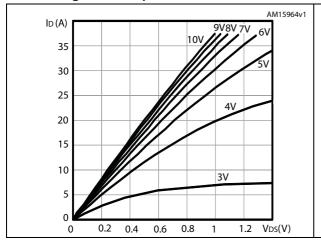


Figure 4. Output characteristics

Figure 5. Transfer characteristics



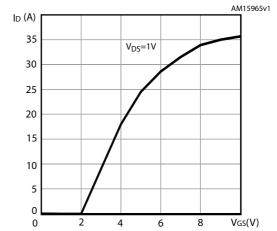
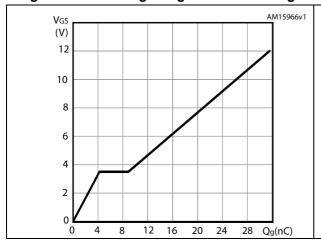
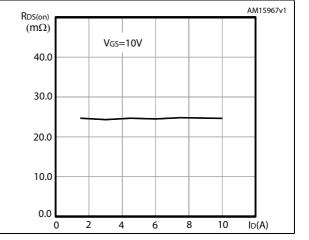


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance



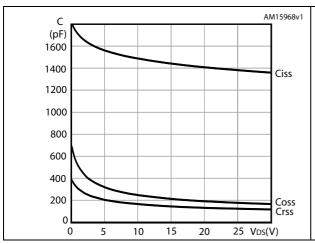


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Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs temperature



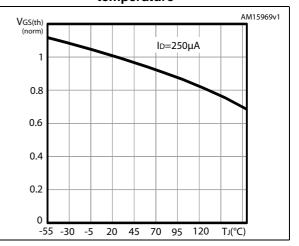
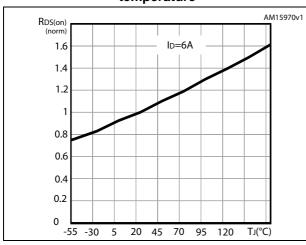


Figure 10. Normalized on-resistance vs temperature

Figure 11. Normalized  $\rm V_{\rm DS}$  vs temperature



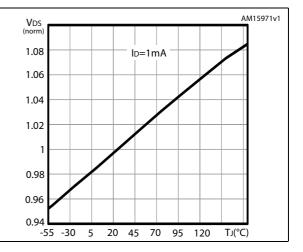
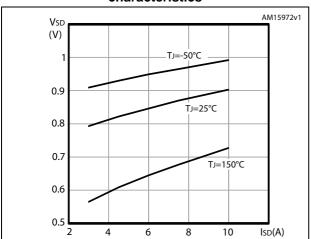


Figure 12. Source-drain diode forward characteristics



Test circuits STD26P3LLH6

## 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

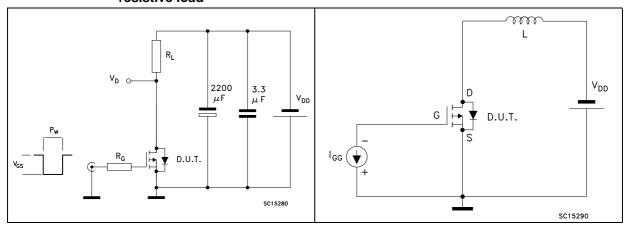
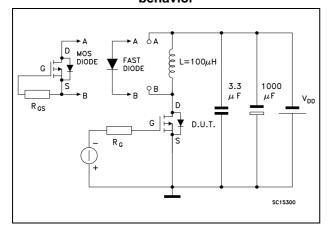


Figure 15. Test circuit for diode recovery behavior



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## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



Table 8. DPAK (TO-252) mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
е		2.28	
e1	4.40		4.60
Н	9.35		10.10
L	1.00		1.50
(L1)		2.80	
L2		0.80	
L4	0.60		1.00
R		0.20	
V2	0°		8°

E -THERMAL PAD c2 *L2* D1 Н <u>b(</u>2x) R C SEATING PLANE (L1) *V2* GAUGE PLANE 0,25 0068772\_K

Figure 16. DPAK (TO-252) drawing

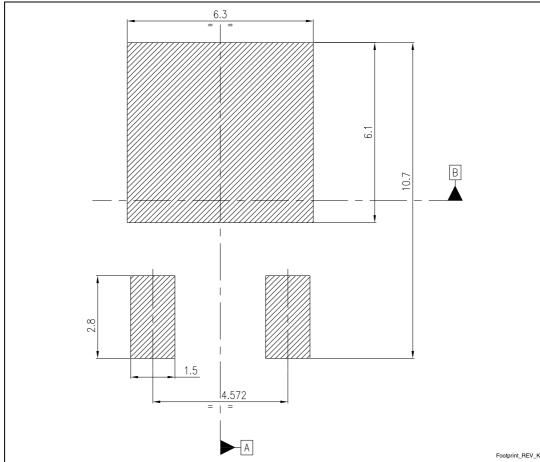


Figure 17. DPAK footprint (a)

a. All dimensions are in millimeters

# 5 Packaging mechanical data

Table 9. DPAK (TO-252) tape and reel mechanical data

	Таре	( / )		Reel	
Dim	r	nm	Dim.	n	nm
Dim.	Min.	Max.	Dim.	Min.	Max.
A0	6.8	7	Α		330
В0	10.4	10.6	В	1.5	
B1		12.1	С	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
Е	1.65	1.85	N	50	
F	7.4	7.6	Т		22.4
K0	2.55	2.75			
P0	3.9	4.1		Base qty.	2500
P1	7.9	8.1		Bulk qty.	2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			



Top cover tolerance on tape +/- 0.2 mm

Top cover tolerance on tape +/- 0.2 mm

For machine ref. only including draft and radii concentric around B0

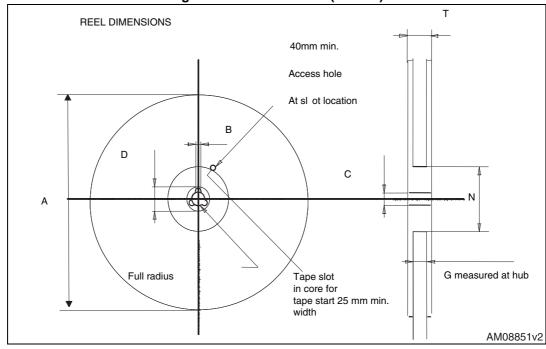
User direction of feed

Bending radius

AM08852v1

Figure 18. Tape for DPAK (TO-252)





STD26P3LLH6 Revision history

# 6 Revision history

Table 10. Document revision history

Date	Revision	Changes
22-Aug-2012	1	First release
31-Jan-2013	2	<ul> <li>Modified: R<sub>DS(on)</sub> on the title, <i>Features</i> table and <i>Table 4</i></li> <li>Modified: typical values on <i>Table 5</i>, 6, 7</li> <li>Modified: V<sub>SD</sub> max value on <i>Table 7</i></li> <li>Updated: <i>Section 4: Package mechanical data</i></li> </ul>
16-Jul-2013	3	<ul> <li>Modified: V<sub>GS</sub> and I<sub>D</sub>=100 °C values in <i>Table 2</i></li> <li>Modified: R<sub>DS(on)</sub> max value in <i>Table 4</i>, <i>Figure 13</i>, <i>14</i> and <i>15</i></li> <li>Inserted: Section 2.1: Electrical characteristics (curves)</li> </ul>
10-Sep-2013	4	- Updated Q <sub>g</sub> value in <i>Table 5: Dynamic</i> .

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